

MOSFET – N-Channel, POWERTRENCH[®], SyncFET[™]

30 V, 49 A, 3.5 mΩ

FDMS0309AS, FDMS0309AS-NC

General Description

The FDMS0309AS has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $R_{DS(on)}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Features

- Max $R_{DS(ON)} = 3.5\text{ m}\Omega$ @ $V_{GS} = 10\text{ V}$, $I_D = 21\text{ A}$
- Max $R_{DS(ON)} = 4.3\text{ m}\Omega$ @ $V_{GS} = 4.5\text{ V}$, $I_D = 19\text{ A}$
- Advanced Package and Silicon Combination for Low $R_{DS(on)}$ and High Efficiency
- SyncFET Schottky Body Diode
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

Applications

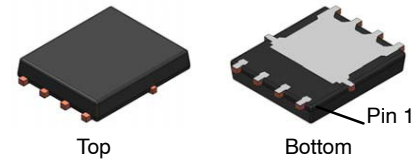
- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/GPU Low Side Switch
- Networking Point of Load Low Side Switch
- Telecom Secondary Side Rectification

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DS}	Drain to Source Voltage	30	V
V_{DSst}	Drain to Source Transient Voltage ($t_{Transient} < 100\text{ ns}$)	33	V
V_{GS}	Gate to Source Voltage (Note 4)	± 20	V
I_D	Drain Current Continuous (Package Limited) $T_C = 25\text{ }^\circ\text{C}$ Continuous (Silicon Limited) $T_C = 25\text{ }^\circ\text{C}$ Continuous (Note 1a) $T_A = 25\text{ }^\circ\text{C}$ Pulsed	49 96 21 100	A
E_{AS}	Single Pulse Avalanche Energy (Note 3)	66	mJ
P_D	Power Dissipation $T_C = 25\text{ }^\circ\text{C}$ (Note 1a) $T_A = 25\text{ }^\circ\text{C}$	50 2.5	W
T_J , T_{STG}	Operating and Storage Junction Temperature Range	-55 to $+150$	$^\circ\text{C}$

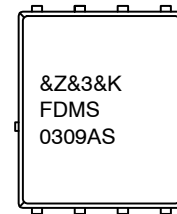
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

V_{DS}	$R_{DS(on)}\text{ MAX}$	$I_D\text{ MAX}$
30 V	3.5 mΩ @ 10 V	49 A
	4.3 mΩ @ 4.5 V	



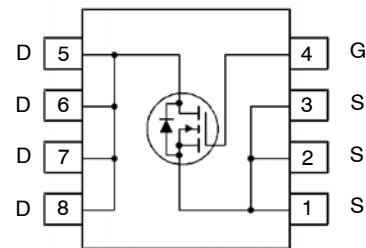
PQFN8 5x6, 1.27P
(Power 56)
CASE 483AE

MARKING DIAGRAM



&Z	= Assembly Plant Code
&3	= Data Code (Year & Week)
&K	= Lot Code
FDMS0309AS	= Specific Device Code

PIN CONNECTIONS



ORDERING INFORMATION

Device	Package	Shipping [†]
FDMS0309AS	PQFN8	3000 / Tape & Reel
FDMS0309AS-NC	PQFN8	3000 / Tape & Reel

[†] For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, [BRD8011/D](#).

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 1\text{ mA}, V_{GS} = 0\text{ V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 10\text{ mA}$, Referenced to $25\text{ }^{\circ}\text{C}$		25		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{ V}, V_{DS} = 24\text{ V}$			500	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	nA

ON CHARACTERISTICS

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1\text{ mA}$	1.2	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10\text{ mA}$, Referenced to $25\text{ }^{\circ}\text{C}$		-5		mV/°C
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{ V}, I_D = 21\text{ A}$		2.7	3.5	mΩ
		$V_{GS} = 4.5\text{ V}, I_D = 19\text{ A}$		3.4	4.3	
		$V_{GS} = 10\text{ V}, I_D = 21\text{ A}, T_J = 125\text{ }^{\circ}\text{C}$		3.7	4.8	
g_{FS}	Forward Transconductance	$V_{DD} = 5\text{ V}, I_D = 21\text{ A}$		120		S

DYNAMIC CHARACTERISTICS

C_{iss}	Input Capacitance	$V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		2255	3000	pF
C_{oss}	Output Capacitance			815	1085	pF
C_{rss}	Reverse Transfer Capacitance			85	125	pF
R_g	Gate Resistance			1.0	2.5	Ω

SWITCHING CHARACTERISTICS

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15\text{ V}, I_D = 21\text{ A}, V_{GS} = 10\text{ V}, R_{GEN} = 6\text{ }^{\circ}\Omega$		11	19	ns
t_r	Rise Time			4.5	10	ns
$t_{d(off)}$	Turn-Off Delay Time			29	46	ns
t_f	Fall Time			3.7	10	ns
Q_g	Total Gate Charge	$V_{GS} = 0\text{ V to }10\text{ V}, V_{DD} = 15\text{ V}, I_D = 21\text{ A}$		34	47	nC
		$V_{GS} = 0\text{ V to }4.5\text{ V}, V_{DD} = 15\text{ V}, I_D = 21\text{ A}$		16	23	nC
Q_{gs}	Gate to Source Charge	$V_{DD} = 15\text{ V}, I_D = 21\text{ A}$		5.9		nC
Q_{gd}	Gate to Drain "Miller" Charge			4.6		nC

DRAIN-SOURCE DIODE CHARACTERISTICS

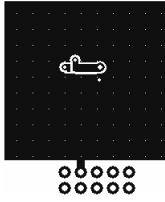
V_{SD}	Source-Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 2\text{ A (Note 2)}$		0.6	0.8	V
		$V_{GS} = 0\text{ V}, I_S = 21\text{ A (Note 2)}$		0.8	1.2	
t_{rr}	Reverse Recovery Time	$I_F = 21\text{ A}, di/dt = 300\text{ A}/\mu\text{s}$		26	42	ns
Q_{rr}	Reverse Recovery Charge			27	44	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

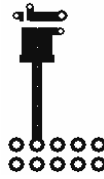
FDMS0309AS, FDMS0309AS-NC

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



- a.) 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



- b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0 %.
3. E_{AS} of 66 mJ is based on starting $T_J = 25$ °C, $L = 0.3$ mH, $I_{AS} = 21$ A, $V_{DD} = 27$ V, $V_{GS} = 10$ V.
4. As an N-ch device, the negative V_{GS} rating is for low duty cycle pulse occurrence only. No continuous rating is implied.



TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

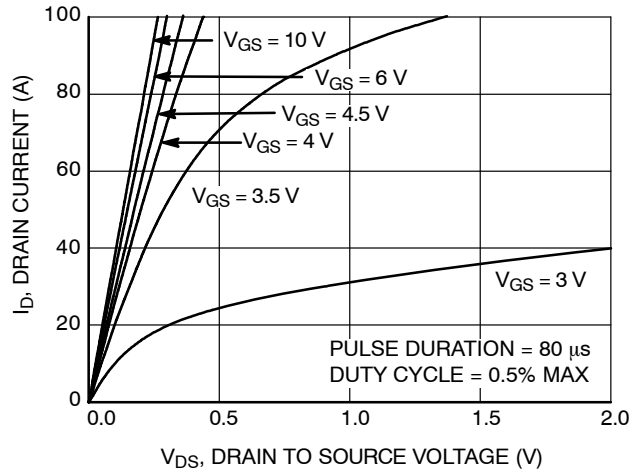


Figure 1. On Region Characteristics

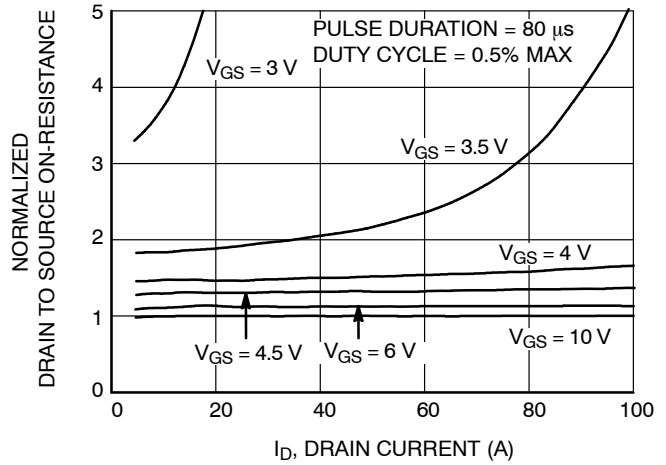


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

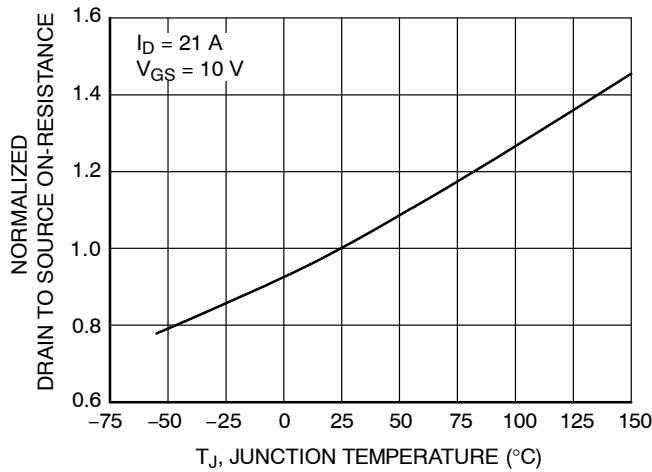


Figure 3. Normalized On-Resistance vs. Junction Temperature

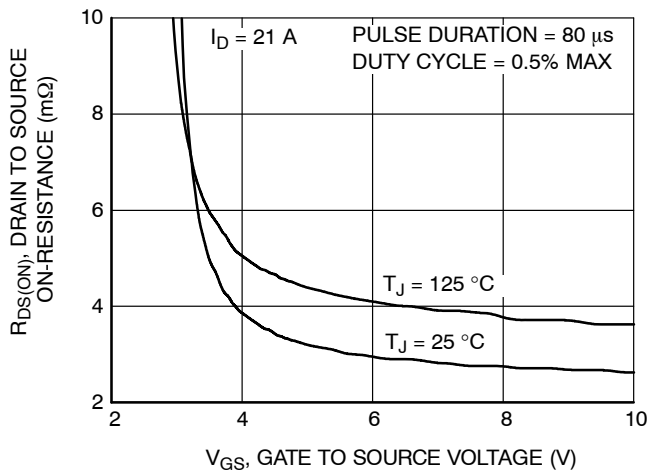


Figure 4. On-Resistance vs. Gate to Source Voltage

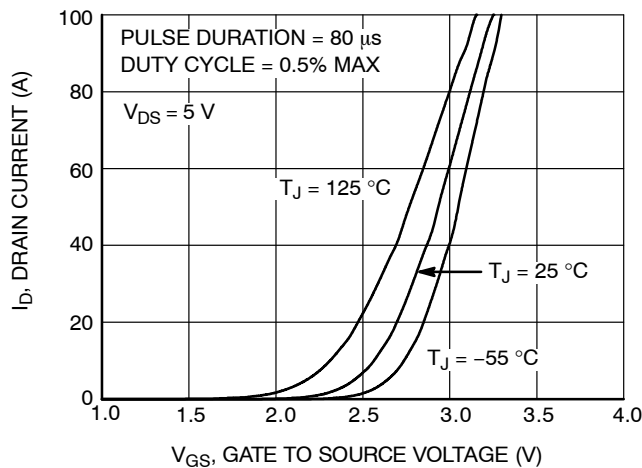


Figure 5. Transfer Characteristics

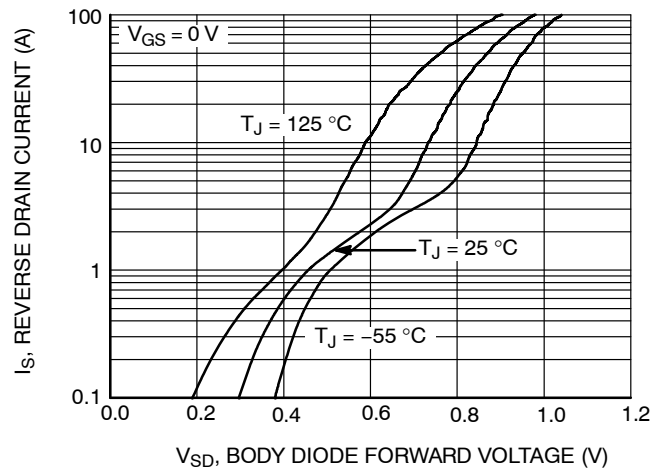


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

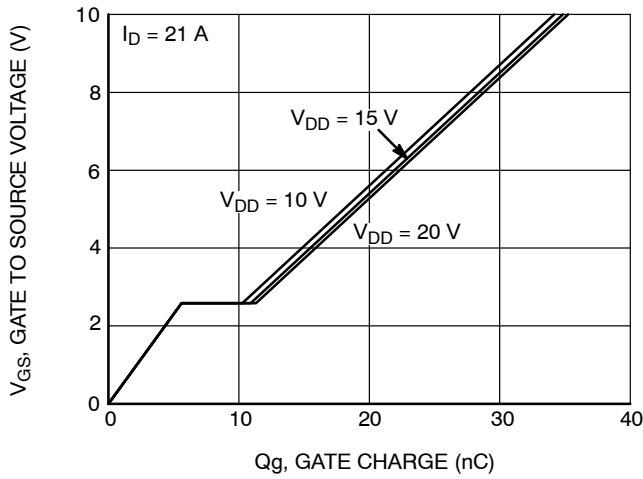


Figure 7. Gate Charge Characteristics

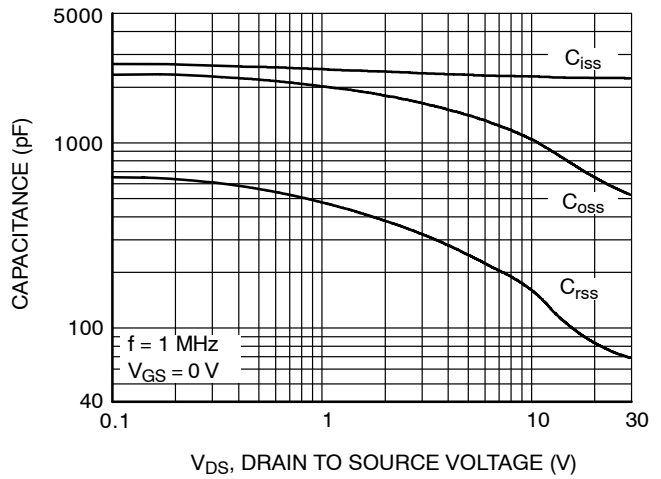


Figure 8. Capacitance vs. Drain to Source Voltage

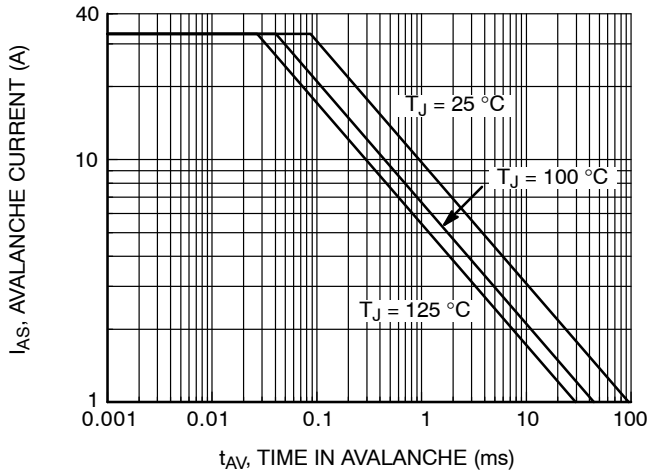


Figure 9. Unclamped Inductive Switching Capability

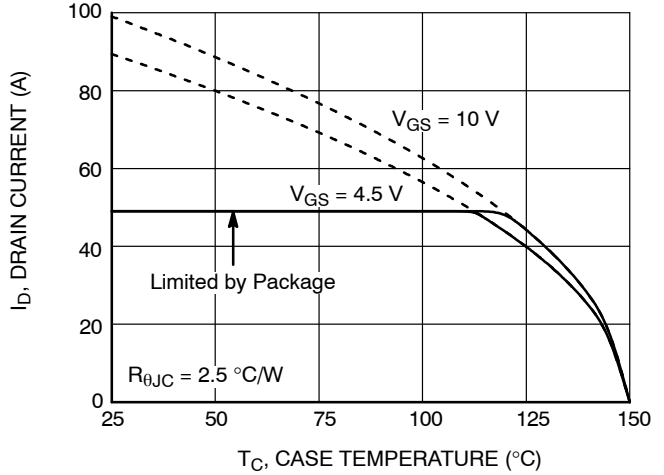


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

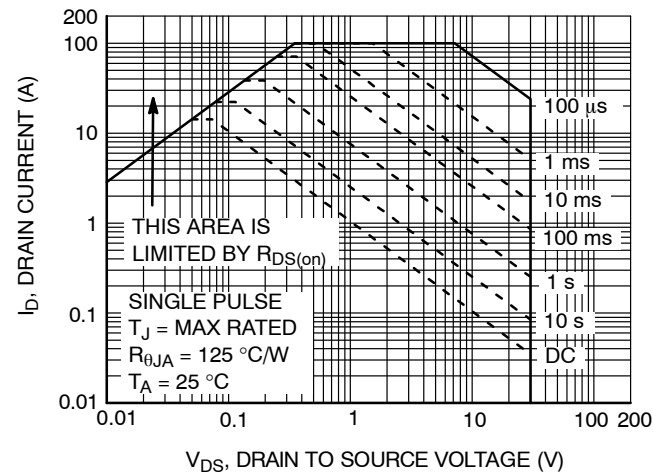


Figure 11. Forward Bias Safe Operating Area

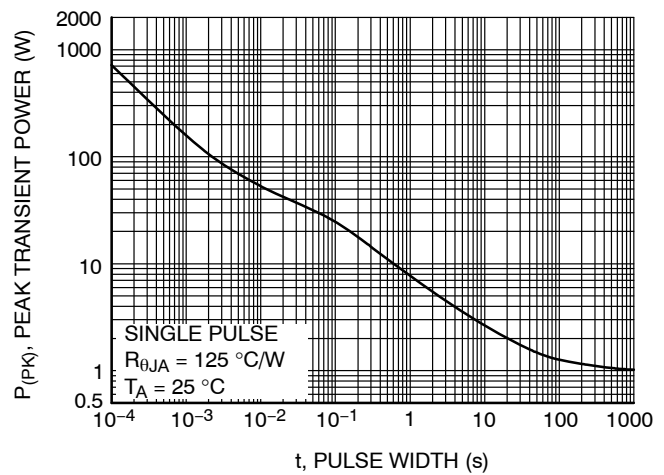


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise noted) (continued)

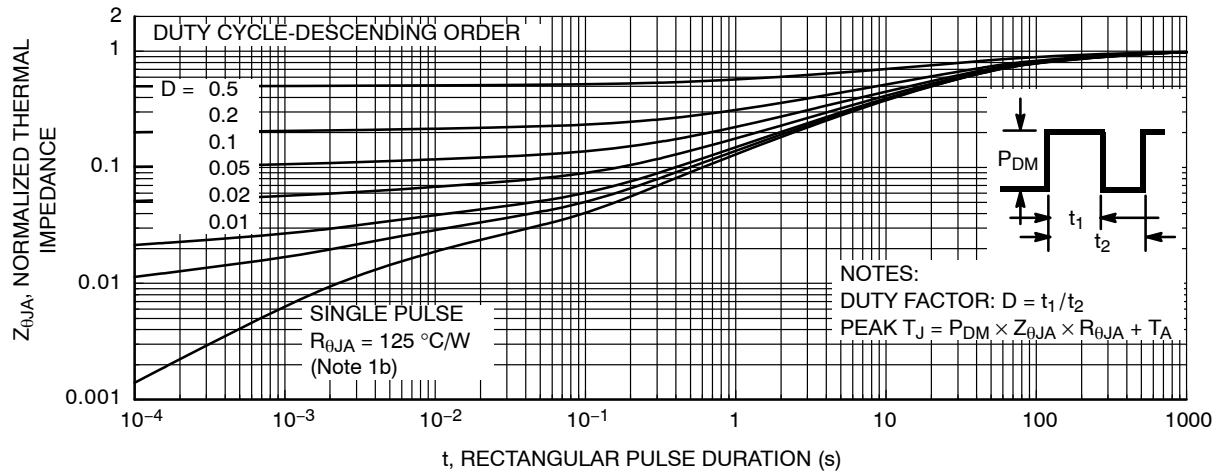


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

SyncFET Schottky Body Diode Characteristics

onsemi's SyncFET™ process embeds a Schottky diode in parallel with POWERTRENCH MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows

the reverse recovery characteristic of the FDMS0309AS. Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

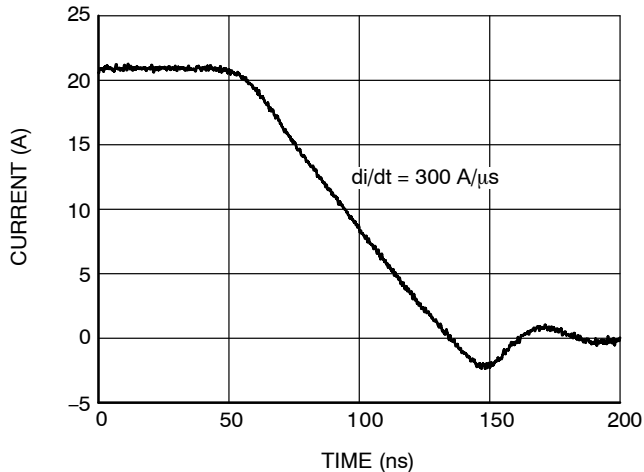


Figure 14. FDMS0309AS SyncFET Body Diode Reverse Recovery Characteristics

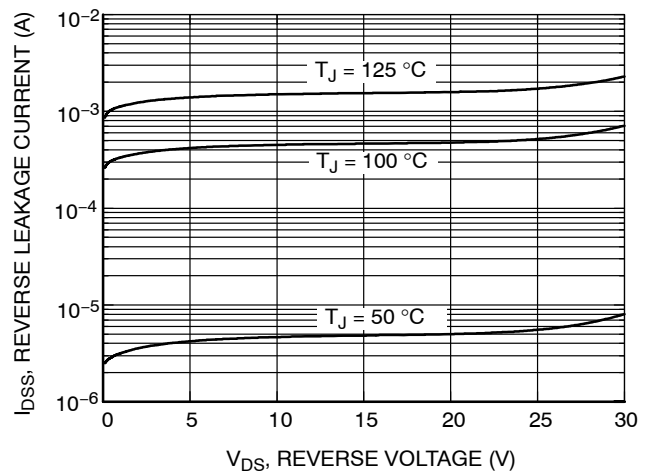


Figure 15. SyncFET Body Diode Reverse Leakage versus Drain-Source Voltage

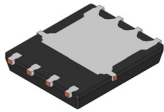
FDMS0309AS, FDMS0309AS-NC

REVISION HISTORY

Revision	Description of Changes	Date
3	Document converted to onsemi format; OPN FDMS0309AS-NC added.	9/7/2026

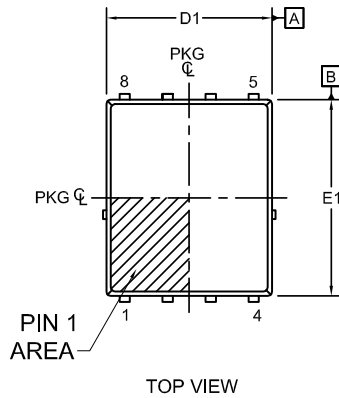
This document has undergone updates prior to the inclusion of this revision history table. The changes tracked here only reflect updates made on the noted approval dates.



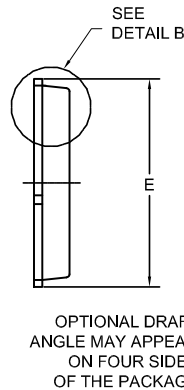


PQFN8 5X6, 1.27P
CASE 483AE
ISSUE C

DATE 21 JAN 2022

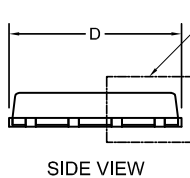


TOP VIEW

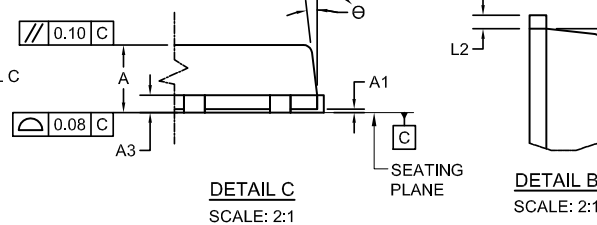


NOTES:

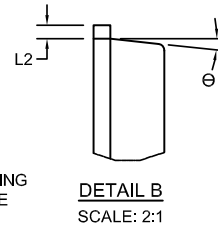
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.



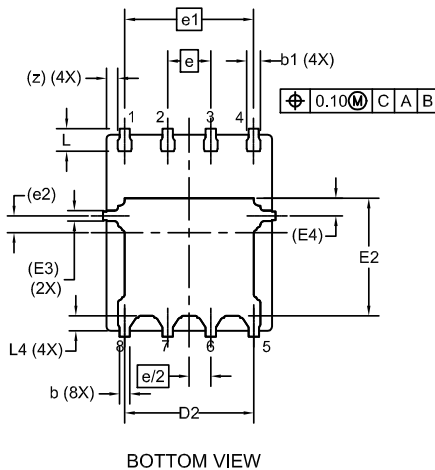
SIDE VIEW



DETAIL C
SCALE: 2:1



DETAIL B
SCALE: 2:1



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